

RADIO TEST REPORT

Test Report No.: 10835000S

Applicant	:	NIDEC SANKYO CORPORATION
Type of Equipment	:	Transmitter Module
Model No.	:	ІСТОМО
FCC ID	:	WJ6-0AM000001A-M
Test regulation	:	FCC Part15 Subpart C: 2015
Test result	:	Complied

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Date of test:

Representative test engineer:

an

June 16 to 19, 2015

Akira Sato Engineer Consumer Technology Division

Approved by :

m

Toyokazu Imamura Leader Consumer Technology Division



The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan. There is no testing item of "Non-accreditation".

UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN Telephone : +81 463 50 6400 Facsimile : +81 463 50 6401

13-EM-F0429

REVISION HISTORY

Original Test Report No.: 10835000S

Revision	Test report No.	Date	Page revised	Contents
- (Original)	10835000S	June 25, 2015	-	-
1	10835000S	July 6, 2015	4	Correction of comment for FCC 15.203 / 212

Contents

Page

SECTION 1: Customer information	
SECTION 2: Equipment under test (E.U.T.)	4
SECTION 3: Test specification, procedures & re	sults5
SECTION 4: Operation of E.U.T. during testing	7
SECTION 5: Conducted emission	
SECTION 5: Radiated emission (Fundamental a	nd Spurious emission)9
SECTION 6: 20dB bandwidth & Occupied band	width (99%)11
SECTION 7: Frequency tolerances	
Contents of APPENDIXES	
APPENDIX 1: Data of Radio tests	
APPENDIX 2: Test instruments	
APPENDIX 3: Photographs of test setup	

SECTION 1: Customer information

Company Name	:	NIDEC SANKYO CORPORATION
Address	:	5329, Shimosuwa-machi, Suwa-gun, Nagano, 393-8511 Japan
Telephone Number	:	+81-266-27-4774
Facsimile Number	:	+81-266-27-4620
Contact Person	:	Junro Takeuchi

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of equipment	:	Transmitter Module
Model No.	:	ICT0M0
Serial No.	:	Refer to 4.2.
Rating	:	DC 24 V
Country of Mass-production	:	Japan
Condition of EUT	:	Production model
Receipt Date of Sample	:	June 12, 2015

2.2 Product description

Model: ICT0M0 (referred to as the EUT in this report) is a Transmitter Module.

Clock frequency(ies) in the system : 13.56 MHz, 16 MHz

Radio part:		
Equipment type	:	Transceiver
Frequency of operation	:	13.56MHz
Type of modulation	:	ASK
Antenna type	:	Loop
Antenna connector type	:	Ultra Miniature Coaxial
ITU code	:	A1D

FCC 15.31 (e)

The RF Module has its own regulator. The RF Module is constantly provided voltage (DC 3.3 V and 5.0 V) through the regulator regardless of input voltage. Therefore, this EUT complies with the requirement.

FCC 15.203 / 212

The EUT has a unique coupling/antenna connector. Therefore the equipment complies with the requirement.

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SECTION 3: Test specification, procedures & results

3.1 Test specification

Test specification: FCC Part 15 Subpart C: 2015, final revised on January 21, 2015Title: FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.207 Conducted limits
Section 15.209 Radiated emission limits, general requirements
Section 15.215 Additional provisions to the general radiated emission limitations
Section 15.225 Operation within the band 13.110-14.010MHz

Item **Test Procedure** Specification **Remarks** Deviation Worst Margin Results ANSI C63.4:2009 10.4 dB Conducted 7. AC powerline FCC 15.207 N/A Freq.: 13.55970 MHz Complied conducted emission emission Phase: N measurements Electric field strength ANSI C63.4:2009 67.7 dB of Fundamental 13. Measurement of Radiated N/A Complied FCC 15.225 (a) Polarization: Vertical intentional radiators emission Electric field strength of Spurious emission 45.9 dB ANSI C63.4:2009 FCC 15.225 (within the 13. Measurement of Radiated N/A Freq.: 14.010 MHz Complied (b)(c) intentional radiators 13.110-14.010MHz Polarization: Horizontal band) Electric field strength of Spurious emission 4.2 dB ANSI C63.4:2009 FCC 15.209 (outside of the N/A 13. Measurement of Radiated Freq.: 245.547 MHz Complied FCC 15.225 (d) intentional radiators Polarization: Horizontal 13.110-14.010MHz band) ANSI C63.4:2009 20dB bandwidth 13. Measurement of FCC 15.215 (c) Radiated N/A intentional radiators ANSI C63.4:2009 13. Measurement of Frequency tolerance FCC 15.225 (e) Radiated N/A Complied intentional radiators Note: UL Japan's Work Procedures No. 13-EM-W0420 and 13-EM-W0422

3.2 Procedures & Results

3.3 Addition to standard

Item	Test Procedure	Specification	Remarks	Worst Margin	Results	
Occupied Bandwidth (99%)	ANSI C63.4:2009 13. Measurement of intentional radiators, RSS-Gen 6.6	-	Radiated	-	-	
Note: UL Japan's Work Procedures No. 13-EM-W0420 and 13-EM-W0422						

* Other than above, no addition, exclusion nor deviation has been made from the standard.

 Test report No. : 10835000S

 Page
 : 6 of 26

 Issued date
 : June 25, 2015

 FCC ID
 : WJ6-0AM000001A-M

3.4 Uncertainty

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Item	Frequency range	No.1 SAC ^{*1} /SR ^{*2} (\pm)	No.2 SAC/SR (±)	No.3 SAC/SR (±)
Conducted emission	9 kHz-150 kHz	4.0 dB	3.8 dB	3.8 dB
(AC Mains) AMN/LISN	150 kHz-30 MHz	3.6 dB	3.4 dB	3.4 dB
Radiated emission	9 kHz-30 MHz	3.7 dB	3.5 dB	3.5 dB
(Measurement distance: 3m)	30 MHz-300 MHz	4.9 dB	4.9 dB	4.7 dB
	300 MHz-1 GHz	5.0 dB	5.0 dB	4.8 dB
	1 GHz-18 GHz	4.9 dB	4.9 dB	4.9 dB
	18 GHz-26.5 GHz	4.5 dB	4.3 dB	4.3 dB

*1: SAC=Semi-Anechoic Chamber

*2: SR= Shielded Room is applied besides radiated emission

Conducted emission

The data listed in this test report has enough margin, more than site margin.

Radiated emission

The data listed in this report meets the limits unless the uncertainty is taken into consideration.

Other tests

Frequency (Normal condition) Measurement uncertainty for this test was: (\pm) 7.9 x 10^-8. Frequency (Extreme condition) Measurement uncertainty for this test was: (\pm) 7.9 x 10^-8. Bandwidth Measurement uncertainty for this test was: (\pm) 0.66% Temperature uncertainty for this test was: (\pm) 0.95deg.C Voltage uncertainty for this test was: (\pm) 0.24%

3.5 Test location

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relephone number	•	± 61405500400	
Facsimile number	:	+81 463 50 6401	
JAB Accreditation No.	:	RTL02610	

	IC Registration No.	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Maximum measurement distance
No.1 Semi-anechoic chamber	2973D-1	20.6 x 11.3 x 7.65	20.6 x 11.3	10 m
No.2 Semi-anechoic chamber	2973D-2	20.6 x 11.3 x 7.65	20.6 x 11.3	10 m
No.3 Semi-anechoic chamber	2973D-3	12.7 x 7.7 x 5.35	12.7 x 7.7	5 m
No.4 Semi-anechoic chamber	-	8.1 x 5.1 x 3.55	8.1 x 5.1	-
No.1 shielded room	-	6.8 x 4.1 x 2.7	6.8 x 4.1	-
No.2 shielded room	-	6.8 x 4.1 x 2.7	6.8 x 4.1	-
□ No.3 shielded room	-	6.3 x 4.7 x 2.7	6.3 x 4.7	-
No.4 shielded room	-	4.4 x 4.7 x 2.7	4.4 x 4.7	-
No.5 shielded room	-	7.8 x 6.4 x 2.7	7.8 x 6.4	-
No.6 shielded room	-	7.8 x 6.4 x 2.7	7.8 x 6.4	-
No.1 Measurement room	-	2.55 x 4.1 x 2.5	-	-

3.6 Test setup, Data of test & Test instruments

Refer to APPENDIX 1 to 3.

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SECTION 4: Operation of E.U.T. during testing

4.1 Operating mode

The EUT exercise program used during testing was designed to exercise the various system components in a manner similar to typical use.

Test item	Operating mode	Tested frequency		
All items	Transmitting	13.56MHz		
Seturate for testing MET209, 2221DLL dll over 2040.01A				

Software for testing: MST3Q8_3331DLL.dll ver. 3040-01A

The carrier level and noise levels were confirmed with and without Card, and the test was made with the condition that has the maximum noise.

Justification: The system was configured in typical fashion (as customer would normally use it) for testing.

4.2 Configuration and peripherals

Standard ferrite core



*Cabling and setup were taken into consideration and test data was taken under worse case conditions.

No.	Item	Model number	Serial number	Manufacturer	Remarks
А	Transmitter Module	ICT0M0	001	NIDEC SANKYO	EUT
В	Desktop PC	FMV6667CLS	3136	Fujitsu	-
С	Monitor	VL-1530S	DF0238060	Fujitsu	-
D	Keyboard	RT6670_TJP	61651546	HP	-
Е	Mouse	ECM-S5002 /R64-1229-07	4Y15527	NEC	-
F	Contactless IC Card	T1-C1	-	NIDEC SANKYO	-
G	Contactless IC card / Magnetic card dispenser	SCT3Q8-3AM232	DS R-5050003	NIDEC SANKYO	-

Description of EUT and Support equipment

List of cables used

No.	Item Length (m) Shield (Cable)		Shield (Cable)	Shield (Connector)	Remarks
1	DC	1.3	Unshielded	Unshielded	-
2	RS-232 C	32 C 3.0 Shielded		Shielded	-
3	RGB	1.27	Unshielded	Unshielded	-
4	Mouse	1.8	Unshielded	elded Unshielded	
5	Keyboard	2.8	Shielded	Unshielded	-
6	AC	2.0	Shielded	Shielded	-
7	AC	1.7	Unshielded	Unshielded	-

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 Test report No.
 : 10835000S

 Page
 : 8 of 26

 Issued date
 : June 25, 2015

 FCC ID
 : WJ6-0AM000001A-M

SECTION 5: Conducted emission

5.1 Operating environment

Test place	:	See test data (APPENDIX 1)
Temperature	:	See test data (APPENDIX 1)
Humidity	:	See test data (APPENDIX 1)

5.2 Test configuration

EUT was placed on a platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane. The table is made of Styrofoam and covered with polyvinyl chloride. That has very low permittivity.

The rear of tabletop was located 40 cm to the vertical conducting plane. The rear of peripheral was aligned and was flushed with rear of tabletop. All other surfaces of tabletop were at least 80 cm from any other grounded conducting surface. EUT was located 80 cm from LISN. Each EUT current-carrying power lead, except the ground (safety) lead, was individually connected through a LISN to the input power source. All unused 500hm connectors of the LISN were resistively terminated in 50 ohm when not connected to the measuring equipment. Photographs of the set up are shown in APPENDIX 3.

5.3 Test conditions

Frequency range	:	0.15 MHz - 30 MHz
EUT position	:	Table top

5.4 Test procedure

The AC Mains Terminal Continuous disturbance Voltage had been measured with the EUT within a Shielded room. The EUT was connected to a Line Impedance Stabilization Network (LISN). An overview sweep with peak detection has been performed.

The measurements had been performed with a quasi-peak detector and if required, a CISPR average detector. The conducted emission measurements were made with the following detection of the test receiver.

luucteu emission n	icust	irements were made with the fond
Detection Type	:	Quasi-Peak/ CISPR Average
IF Bandwidth	:	9 kHz

5.5 Results

Summary of the test results : Pass Refer to APPENDIX 1

SECTION 6: Radiated emission (Fundamental and Spurious emission)

6.1 Operating environment

Test place	:	See test data (APPENDIX 1)
Temperature	:	See test data (APPENDIX 1)
Humidity	:	See test data (APPENDIX 1)

6.2 Test configuration

EUT was placed on a platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane. The table is made of Styrofoam and covered with polyvinyl chloride. That has very low permittivity. Photographs of the set up are shown in Appendix 1.

6.3 Test conditions

Frequency range	:	9 kHz - 1 GHz
Test distance	:	3 m
EUT position	:	Table top

6.4 Test procedure

The Radiated Electric Field Strength intensity has been measured on a semi-anechoic chamber with a ground plane at a distance of 3 m.

Although these tests were performed other than open area test site, adequate comparison measurements were confirmed against 30 m open are test site. Therefore sufficient tests were made to demonstrate that the alternative site produces results that correlate with the ones of tests made in an open field based on KDB 937606. These tests were performed in semi anechoic chamber. Therefore the measured level of emissions may be higher than if measurements were made without a ground plane. However test results were confirmed to pass against standard limit.

The Radiated Electric Field Strength intensity has been measured with a ground plane and at a distance of 3 m Frequency: From 9 kHz to 30 MHz at distance 3 m

The EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity. The measurements were performed for vertical polarization (antenna angle: 0 deg.to 360 deg.) and horizontal polarization. Drawing of the antenna direction is shown in Figure 1.

Frequency: From 30 MHz to 1 GHz at distance 3 m (Refer to Figure 2).

The measuring antenna height was varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization.

Measurements were performed with QP, PK, and AV detector.

The radiated emission	measurements were	e made with	the following	ng detector	function of	of the test re	ceiver.
				0			

	9 kHz to 90 kHz &	90 kHz to	150 kHz	490 kHz to	30 MHz to 1 GHz
	110 kHz to 150 kHz	110 kHz	to 490 kHz	30 MHz	
Detector Type	PK/AV	QP	PK/AV	QP	QP
IF Bandwidth	200 Hz	200 Hz	9 kHz	9 kHz	120 kHz
Measuring		Loop anter		Biconical (30 MHz-299.99 MHz)	
antenna					Logperiodic (300 MHz-1 GHz)

* FCC 15.31 (f)(2) (9 kHz-30 MHz)

9 kHz – 490 kHz [Limit at 3 m]= [Limit at 300 m]-40 log (3 [m]/300 [m]) 490 kHz – 30 MHz [Limit at 3 m]= [Limit at 30 m]-40 log (3 [m]/30 [m])

The EUT was tested in the direction normally used.

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6.5 Results

Summary of the test results :

No spurious emissions exceeded the fundamental emission level.

Refer to APPENDIX 1.

Figure 1. Direction of the Loop Antenna

Pass

Horizontal (Top View)



Figure 2. Antenna angle



SECTION 7: 20dB bandwidth & Occupied bandwidth (99%)

Test procedure

The test was measured with a spectrum analyzer using a test fixture.

Results

Summary of the test results: Pass Refer to APPENDIX 1.

SECTION 8: Frequency tolerances

Test procedure

Refer to APPENDIX 1.

The test was measured with a spectrum analyzer using a test fixture. The temperature test was started after the temperature stabilization time of 30 minutes. The test was begun from 50 deg.C and the temperature was lowered each 10 deg.C.

Results

Summary of the test results: Pass

 Test report No. : 10835000S

 Page
 : 12 of 26

 Issued date
 : June 25, 2015

 FCC ID
 : WJ6-0AM000001A-M

Contents of APPENDIXES

APPENDIX 1: Data of Radio tests

Conducted emission Radiated emission Frequency tolerance Bandwidth

APPENDIX 2: Test instruments

Test instruments

APPENDIX 3: Photographs of test setup

Conducted emission Radiated emission Pre-check of the worst case Tag used for the test as representative

DATA OF CONDUCTED EMISSION TEST

UL Japan,Inc. Shonan EMC Lab. No.1 Shielded Room Date : 2015/06/19



 $\label{eq:calculation:Result [dBuV] = Reading [dBuV] + C.Fac (LISN+Cable+ATT) [dB] \\ LISN:SLS-01 \\$

DATA OF CONDUCTED EMISSION TEST

UL Japan, Inc. Shonan EMC Lab. No.1 Shielded Room

Date : 2015/06/19

Company Kind of EUT	:	NIDEC SANKYO CORPORATION Transmitter Module	Mode Order No.	:	Transmitting (13.56MHz) 10835000S
Model No. Sorial No.	÷		Power Tomp /Humi	:	DC 24 V, AC 120 V / 60 HZ (DC PS)
Remarks	÷	with card	remp./ num.	•	24deg.C. / 04/066

Engineer

: Akira Sato

<<	QP/AV DAT	<< A										
	From	Rea	ding	C Eao	Res	ults	Lir	nit	Ma	rgin		
No.	Fleg.	<qp></qp>	<av></av>		<qp></qp>	<av></av>	<qp></qp>	<av></av>	<qp></qp>	<av></av>	Phase	Comment
—											N	
	0.19200	21.1	2.2	12.8	33.9	15.0	60.2	53.9	30.0	38.9	N	
2	0.29471	12.5	0.2	12.0	25.3	13.0	56.0	46.0	30.3	30.5	N	
4	1 54003	14.4	-23	12.0	27.3	10.0	56.0	46.0	28.7	35.4	N	
5	2.07822	19.4	-0.4	12.9	32.3	12.5	56.0	46.0	23.7	33.5	N	
6	2.51745	15.2	2.8	12.9	28,1	15.7	56.0	46.0	27.9	30.3	N	
7	2.53682	24.0	18.2	12.9	36.9	31.1	56.0	46.0	19.1	14.9	Ν	
8	3.01353	20.4	17.6	13.0	33.4	30.6	56.0	46.0	22.6	15.4	Ν	
9	3.11340	23.6	15.0	13.0	36.6	28.0	56.0	46.0	19.4	18.0	Ν	
10	3.69308	18.6	0.5	13.0	31.6	13.5	56.0	46.0	24.4	32.5	N	
11	13.55970	32.3	26.1	13.5	45.8	39.6	60.0	50.0	14.2	10.4	N	
12	15.94330	22.6	21.7	13.5	36.1	35.2	60.0	50.0	23.9	14.8	N	
14	0.19200	21.0	2.2	12.0	20.0	13.0	60.9 60.3	50.9 50.2	30.1	30.9	11	
15	0.50040	12.5	0.2	12.0	25.3	13.0	56.0	46.0	30.4	33.0	11	
16	1.53880	14.0	-2.3	12.9	26.9	10.6	56.0	46.0	29.1	35.4	L1	
17	2.07770	19.7	-0.3	12.9	32.6	12.6	56.0	46.0	23.4	33.4	L1	
18	2.53151	17.3	6.1	12.9	30.2	19.0	56.0	46.0	25.8	27.0	L1	
19	2.53974	23.8	18.1	12.9	36.7	31.0	56.0	46.0	19.3	15.0	L1	
20	3.01363	20.2	17.5	13.0	33.2	30.5	56.0	46.0	22.8	15.5	L1	
21	3.10787	17.4	13.0	13.0	30.4	26.0	56.0	46.0	25.6	20.0	L1	
22	3.69472	16.6	0.1	13.0	29.6	13.1	56.0	46.0	26.4	32.9	L1	
23	13.55962	29.4	23.0	13.5	42.9	36.5	60.0 60.0	50.0	17.1	13.5	L1	
24	15.94350	17.4	10.4	13.5	30.9	29.9	00.0	50.0	29.1	20.1	L1	

Data of Electric field strength of Fundamental emission and Spurious emission within the band: FCC15.225(a)(b)(c)

		Shonan EMC Lab., No.2 Semi Anechoic Chamber						
Company:	NIDEC SANKYO CORPORATION	Regulation:	FCC Part15 Subpart C 15.225					
Equipment:	Transmitter Module	Test Distance:	3m					
Model:	ICT0M0	Date:	06 16, 2015					
Sample No.:	001	Temperature:	22 deg.C					
Power:	DC24V	Humidity:	62 %RH					
Mode:	Transmitting 13.56MHz	ENGINEER:	Akira Sato					

Remarks: : Vertical polarization (antenna angle) of the worst case: 0deg, without card

Fundamental emission

No.	FREQ	Test Receiver		Antenna	Loss	AMP	Distance	RES	ULT	LIMIT	MARGIN	
		Reading		Factor		GAIN	factor			(30m)		
		Hor	Ver					Hor	Ver		Hor	Ver
	[MHz]	[dBuV]	[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dB]	[dB]
1	13.560	62.9	63.1	18.6	6.4	31.9	-40.0	16.0	16.2	83.9	67.9	67.7

Calculation:Result[dBuV/m]=Reading[dBuV]+Ant.Fac[dB/m]+Loss(Cable+ATT)[dB]-Gain(AMP)[dB]+Distance factor[dB] Distance factor: 40 x log (3m/30m) = -40 dB

Limits (30m)

•13.553MHz to 13.567MHz : 83.9dBuV/m (FCC 15.225(a))

Spurious emission within the band

No.	FREQ	Test Receiver		Antenna	Loss	AMP	Distance	RESULT		LIMIT	MARGIN	
		Rea	ding	Factor		GAIN	factor					
		Hor	Ver					Hor	Ver		Hor	Ver
	[MHz]	[dBuV]	[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dB]	[dB]
1	13.110	30.3	30.2	18.6	6.4	31.9	-40.0	-16.6	-16.7	29.5	46.1	46.2
2	13.410	32.2	32.5	18.6	6.4	31.9	-40.0	-14.7	-14.4	40.5	55.2	54.9
3	13.553	50.2	50.3	18.6	6.4	31.9	-40.0	3.3	3.4	50.4	47.1	47.0
4	13.567	47.5	47.5	18.6	6.4	31.9	-40.0	0.6	0.6	50.4	49.8	49.8
5	13.710	31.9	31.8	18.5	6.5	31.9	-40.0	-15.0	-15.1	40.5	55.5	55.6
6	14.010	30.5	30.4	18.5	6.5	31.9	-40.0	-16.4	-16.5	29.5	45.9	46.0

Calculation:Result[dBuV/m]=Reading[dBuV]+Ant.Fac[dB/m]+Loss(Cable+ATT)[dB]-Gain(AMP)[dB]+Distance factor[dB]

Outside filed strength frequencies •Fc±7kHz:13.553MHz to 13.567MHz •Fc±150kHz:13.410MHz to 13.710MHz •Fc±450kHz:13.110MHz to 14.010MHz Fc = 13.56MHz

Limits (30m)

·13.410MHz to 13.553MHz and 13.567MHz to 13.710MHz : 50.4dBuV/m (FCC 15.225(b))

·13.110MHz to 13.410MHz and 13.710MHz to 14.010MHz : 40.5dBuV/m (FCC 15.225(c))

·Below 13.110MHz and Above 14.010MHz : 29.5dBuV/m (FCC 15.225(d)and FCC 15.209)

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Radiated Emission (above 30MHz)

UL Japan, Inc. Shonan EMC Lab. No.2 Semi Anechoic Chamber

Regulation: Test Distance: Date: Temperature: Humidity: ENGINEER: FCC Part15 Subpart C 15.225 3m 06 16, 2015 22 deg.C 62 %RH Akira Sato

Remarks: without card

Company:

Equipment:

Sample No.:

Model:

Power:

Mode:

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Distance Factor	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg.]	
Hori.	27.12	QP	29.8	19.4	6.7	31.9	-40.0	-16.0	29.5	45.5	-	359	at 30m
Hori.	40.68	QP	26.1	14.1	7.1	31.9		15.4	40.0	24.6	289	234	at 3m
Hori.	54.24	QP	25.6	9.5	7.3	31.9		10.5	40.0	29.5	100	359	at 3m
Hori.	135.52	QP	32.7	14.0	8.3	31.7		23.3	43.5	20.2	226	54	at 3m
Hori.	245.547	QP	47.3	16.9	9.3	31.7		41.8	46.0	4.2	137	253	at 3m
Hori.	250.682	QP	44.9	17.0	9.3	31.7		39.5	46.0	6.5	142	264	at 3m
Hori.	256.015	QP	46.2	17.2	9.4	31.7		41.1	46.0	4.9	136	267	at 3m
Hori.	314.472	QP	43.9	14.3	6.6	31.7		33.1	46.0	12.9	108	133	at 3m
Hori.	384.014	QP	43.9	15.8	7.1	31.7		35.1	46.0	10.9	100	272	at 3m
Hori.	416.018	QP	38.2	16.4	7.3	31.6		30.3	46.0	15.7	100	310	at 3m
Hori.	592.009	QP	33.5	18.9	8.2	31.6		29.0	46.0	17.0	162	2	at 3m
Hori.	944.013	QP	34.2	22.6	9.8	30.5		36.1	46.0	9.9	100	292	at 3m
Vert.	27.12	QP	30.0	19.4	6.7	31.9	-40.0	-15.8	29.5	45.3	-	359	at 30m
Vert.	40.68	QP	36.9	14.1	7.1	31.9		26.2	40.0	13.8	100	14	at 3m
Vert.	54.24	QP	35.7	9.5	7.3	31.9		20.6	40.0	19.4	100	349	at 3m
Vert.	135.52	QP	34.8	14.0	8.3	31.8		25.3	43.5	18.2	100	199	at 3m
Vert.	359.680	QP	32.4	15.3	6.9	31.6		23.0	46.0	23.0	100	228	at 3m
Vert.	672.032	QP	32.7	20.0	8.6	31.5		29.8	46.0	16.2	100	201	at 3m
Vert.	823.511	OP	25.7	21.1	9.3	31.1		25.0	46.0	21.0	100	10	at 3m

 $Result = Reading + Ant Factor + Loss (Cable + ATT + \Delta AF(above 30 MHz)) - Gain(Amprifier) + Distance factor(below 30 MHz) - Distance factor(below 30$

* Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

* Carrier level (Result at 3m): Hor= 56dBuV/m, Ver= 56.2 dBuV/m

NIDEC SANKYO CORPORATION

Transmitter Module

Transmitting 13.56MHz

ICT0M0

DC24V

001

Radiated Emission (Worst mode plot)

Company: Equipment: Model: Sample No.: Power: Mode: NIDEC SANKYO CORPORATION Transmitter Module ICT0M0 001 DC24V Transmitting 13.56MHz UL Japan, Inc. Shonan EMC Lab. No.2 Semi Anechoic Chamber

Regulation:FCTest Distance:3mDate:06Temperature:22Humidity:62ENGINEER:Ak

FCC Part15 Subpart C 15.225 3m 06 16, 2015 22 deg.C 62 %RH Akira Sato

Remarks:

These plots data contains sufficient number to show the trend of characteristic features for EUT. without Tag





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Data of Frequency Tolerance

UL Japan, Inc.

		Shonan EMC Lab. No.5 Shielded room							
Company	NIDEC SANKYO CORPORATION								
Equipment	Transmitter Module	Regulation	FCC Part15 Subpart C 15.225 (e)						
Model	ІСТОМО	Date	June, 17 2015						
Serial No.	001	Temperature	25 deg.C						
Power	DC 24V	Humidity	50 %RH						
Mode	Transmitting 13.56 MHz	ENGINEER	Wataru Kojima						
Temp	Temperature Variation: -20deg.C								

Original Measure Frequency Frequency Limit Test Conditions Frequency Frequency Error torerance (MHz) (MHz) (MHz) (%) (%) startup 13.56 13.559635 -0.000365 -0.00269 0.010 0.010 after 2minutes 13.56 13.559651 -0.000349 -0.00257 after 5minutes 13.56 13.559656 -0.000344-0.00254 0.010 after 10minutes 13.56 13.559659 -0.000341 -0.00251 0.010 **Temperature Variation: -10deg.C** Original Measure Frequency Frequency Limit Test Conditions Frequency Frequency Error torerance (MHz) (MHz) (MHz) (%) (%) 13.56 13.559679 -0.000321 -0.00237 0.010 startup 0.010 after 2minutes 13.56 13.559680 -0.000320 -0.00236 13.56 13.559681 -0.000319 -0.00235 0.010 after 5minutes 13.56 13.559681 -0.000319 -0.00235 0.010 after 10minutes Temperature Variation: 0deg.C Original Measure Frequency Frequency Limit Test Conditions Frequency Frequency Error torerance (MHz) (MHz) (MHz) (%) (%) 13.56 -0.000320 -0.00236 0.010 13.559680 startup after 2minutes 13.56 13.559675 -0.000325 -0.00240 0.010 after 5minutes 13.56 13.559672 -0.000328 -0.00242 0.010 after 10minutes 13.56 13.559671 -0.000329 -0.00243 0.010 **Temperature Variation: 10deg.C** Original Measure Frequency Frequency Limit **Test Conditions** Frequency Frequency Error torerance (MHz) (MHz) (MHz) (%) (%) -0.00253 0.010 startup 13.56 13.559657 -0.000343 after 2minutes 13.56 13.559648 -0.000352 -0.00260 0.010 13.56 after 5minutes 13.559644 -0.000356 -0.00263 0.010 after 10minutes 13.56 13.559643 -0.000357 -0.00263 0.010 Temperature Variation: 20deg.C Original Measure Frequency Frequency Limit Test Conditions Frequency Error torerance Frequency (MHz) (MHz) (%) (MHz) (%) startup 13.56 13.559662 -0.000338 -0.00249 0.010 after 2minutes 13.56 13.559661 -0.000339 -0.00250 0.010

-0.000393

-0.000394

-0.00290

-0.00291

0.010

0.010

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after 5minutes

after 10minutes

13.56

13.56

13.559607

13.559606

Data of Frequency Tolerance

	Original	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	Frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(%)	(%)
startup	13.56	13.559579	-0.000421	-0.00310	0.010
after 2minutes	13.56	13.559571	-0.000429	-0.00316	0.010
after 5minutes	13.56	13.559559	-0.000441	-0.00325	0.010
after 10minutes	13.56	13.559555	-0.000445	-0.00328	0.010
Temperature Vari	ation: 40de	<u>g.C</u>			
	Original	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	Frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(%)	(%)
startup	13.56	13.559504	-0.000496	-0.00366	0.010
after 2minutes	13.56	13.559495	-0.000505	-0.00372	0.010
after 5minutes	13.56	13.559486	-0.000514	-0.00379	0.010
after 10minutes	13.56	13.559484	-0.000516	-0.00381	0.010
Temperature Vari	ation: 50de	g.C			
	Original	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	Frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(%)	(%)
startup	13.56	13.559467	-0.000533	-0.00393	0.010
after 2minutes	13.56	13.559450	-0.000550	-0.00406	0.010
after 5minutes	13.56	13.559448	-0.000552	-0.00407	0.010
after 10minutes	13.56	13.559446	-0.000554	-0.00409	0.010

Temperature Variation: 30deg.C

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Data of Frequency Tolerance

UL Japan, Inc.

		Shonan EMC	Lab. No.5 Shielded room	
Company	NIDEC SANKYO CORPORATION			
Equipment	Transmitter Module	Regulation	FCC Part15 Subpart C 15.225 (e)	
Model	ICT0M0	Date	June, 17 2015	
Serial No.	001	Temperature	25 deg.C	
Power	DC 24V	Humidity	50 %RH	
Mode	Transmitting 13.56 MHz	ENGINEER	Wataru Kojima	

Voltage Variation: DC 20.4 V Temperature Variation: 20deg.C

Temperature Variation. 200eg.C								
	Original	Measure	Frequency	Frequency	Limit			
Test Conditions	Frequency Frequency		Error	torerance				
	(MHz)	(MHz)	(MHz)	(%)	(%)			
startup	13.56	13.559617	-0.000383	-0.00282	0.010			
after 2minutes	13.56	13.559612	-0.000388	-0.00286	0.010			
after 5minutes	13.56	13.559606	-0.000394	-0.00291	0.010			
after 10minutes	13.56	13.559605	-0.000395	-0.00291	0.010			

Voltage Variation: DC 27.6 V Temperature Variation: 20deg.C

	Original	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	Frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(%)	(%)
startup	13.56	13.559613	-0.000387	-0.00285	0.010
after 2minutes	13.56	13.559609	-0.000391	-0.00288	0.010
after 5minutes	13.56	13.559607	-0.000393	-0.00290	0.010
after 10minutes	13.56	13.559606	-0.000394	-0.00291	0.010

20dB bandwidth & 99% Occupied bandwidth: FCC 15.215 / RSS-Gen

Company:	NIDEC SANKYO CORPORATION
Equipment:	Transmitter Module
Model:	ICT0M0
Sample No.:	001
Power:	DC24V
Mode:	Transmitting 13.56MHz without card

UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Regulation: FCC Part15 Subpart C 15.215

Date: June 17, 2015 Temperature: 25 deg.C Humidity: 50 %RH ENGINEER: Wataru Kojima



Transmit Freq Error -446.132 Hz x dB Bandwidth

5.966 kHz



Transmit Freq Error -466.410 Hz 5.410 kHz≭ x dB Bandwidth

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APPENDIX 2 Test Instruments

EMI test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
SAF-02	Pre Amplifier	SONOMA	310N	290212	RE	2015/02/18 * 12
SAT6-02	Attenuator	JFW	50HF-006N	-	RE	2015/02/18 * 12
KAT3-11	Attenuator	JFW IND. INC.	50HF-003N	-	RE	2014/08/27 * 12
SBA-02	Biconical Antenna	Schwarzbeck	BBA9106	91032665	RE	2014/11/22 * 12
SCC-B1/B3/B5 /B7/B8/B13/S RSE-02	Coaxial Cable&RF Selector	Fujikura/Fujikura/Suhne r/Suhner/Suhner/Suhn er/TOYO	8D2W/12DSFA/14 1PE/141PE/141PE /141PE/NS4906	-/0901-270(RF Selector)	RE	2015/04/17 * 12
SCC-B2/B4/B6 /B7/B8/B13/S RSE-02	Coaxial Cable&RF Selector	Fujikura/Fujikura/Suhne r/Suhner/Suhner/Suhn er/TOYO	8D2W/12DSFA/14 1PE/141PE/141PE /141PE/NS4906	-/0901-270(RF Selector)	RE	2015/04/17 * 12
SLA-02	Logperiodic Antenna	Schwarzbeck	UHALP9108A	UHALP 9108-A 0893	RE	2014/11/22 * 12
SOS-03	Humidity Indicator	A&D	AD-5681	4063325	RE	2014/10/30 * 12
STR-01	Test Receiver	Rohde & Schwarz	ESU40	100093	CE	2014/11/11 * 12
STR-07	Test Receiver	Rohde & Schwarz	ESU26	100484	CE/RE	2014/09/03 * 12
SJM-14	Measure	ASKUL	-	-	RE	-
SAEC-02(NSA)	Semi-Anechoic Chamber	ток	SAEC-02(NSA)	2	RE	2014/07/08 * 12
COTS-SEMI-1	EMI Software	TSJ	TEPTO-DV(RE,CE, RFI,MF)	-	CE/RE	-
SLP-02	Loop Antenna	Rohde & Schwarz	HFH2-Z2	100218	RE	2014/11/30 * 12
SAT6-07	Attenuator	JFW	50HF-006N	-	RE	2015/02/18 * 12
SCC-A12/A13/ SRSE-01	Coaxial Cable&RF Selector	Suhner/Suhner/TOYO	RG223U/141PE/N S4906	-/0901-269(RF Selector)	CE	2015/04/17 * 12
SLS-01	LISN	Rohde & Schwarz	ENV216	100511	CE(EUT)	2015/02/24 * 12
SLS-02	LISN	Rohde & Schwarz	ENV216	100512	CE(AE)	2015/02/24 * 12
SAT3-06	Attenuator	JFW	50HF-003N	-	CE	2015/02/18 * 12
SOS-02	Humidity Indicator	A&D	AD-5681	4063343	CE	2014/12/24 * 12
STM-01	Terminator	ТМЕ	CT-01 BP	-	CE	2014/12/19 * 12
SCH-01	Temperature and Humidity Chamber	Espec	PL-1KT	14020837	FT	2015/04/22 * 12
SSA-02	Spectrum Analyzer	Agilent	E4448A	MY48250106	FT, BW	2015/03/26 * 12
SOS-09	Humidity Indicator	A&D	AD-5681	4061484	FT	2014/12/24 * 12
SSCA-01	Search coil	LANGER	RF-R 400-1	02–0634	FT	Pre Check

The expiration date of the calibration is the end of the expired month .

As for some calibrations performed after the tested dates , those test equipment have been controlled by means of an unbroken chains of calibrations .

All equipment is calibrated with valid calibrations . Each measurement data is traceable to the national or international standards.

Test Item :

CE: Conducted emission,

RE: Radiated emission, FT: Frequency Tolerance,

BW: 20dB bandwidth and 99 % Occupied bandwidth